General Description

The MAX9396 consists of a 2:1 multiplexer and a 1:2 demultiplexer with loopback. The multiplexer section (channel B) accepts two differential inputs and generates a single differential output. The demultiplexer section (channel A) accepts a single differential input and generates two parallel differential outputs. The MAX9396 features a loopback mode that connects the input of channel A to the output of channel B and connects the selected input of channel B to the outputs of channel A.

The differential inputs of the MAX9396 accept CML/LVPECL levels and can also accept LVDS inputs with common-mode voltages from +0.6V to (V_{CC} - 0.05V). The differential outputs are LVDS compatible and drive 100 Ω loads.

Three LVCMOS/LVTTL logic inputs control the internal connections between inputs and outputs, one for the multiplexer portion of channel B (BSEL), and the other two for loopback control of channels A and B (LB_SELA and LB_SELB). Independent enable inputs for each differential output pair provide additional flexibility.

Fail-safe circuitry forces the outputs to a differential low condition for undriven inputs or when the common-mode voltage is below +0.6V.

Ultra-low 57ps_{P-P} (typ) pseudorandom bit sequence (PRBS) jitter ensures reliable communications in high-speed links that are highly sensitive to timing error, especially those incorporating clock-and-data recovery, or serializers and deserializers. The high-speed switching performance guarantees 1.25Gbps operation and less than 87ps (max) skew between channels.

The MAX9396 is available in a 32-pin TQFP package and is specified over the -40°C to +85°C extended temperature range.

Applications

High-Speed Telecom/Datacom Equipment Central Office Backplane Clock Distribution DSLAMs Protection Switching

Fault-Tolerant Systems

Pin Configuration and Functional Diagram appear at end of data sheet.

_ Features

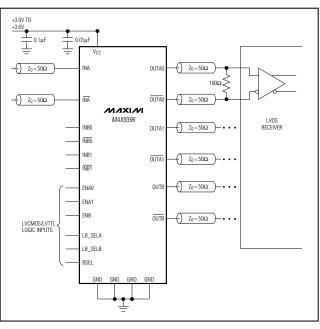
- Guaranteed 1.25Gbps Operation with 450mV (min) Differential Output Swing
- Integrated 100Ω Resistors on Differential Inputs
- Simultaneous Loopback Control
- 2ps_(RMS) (max) Random Jitter
- AC Specifications Guaranteed for 150mV Differential Input
- Signal Inputs Accept Any Differential Signals with V_{CM} = +0.6V to (V_{CC} - 0.05V)
- LVDS Outputs for Clock or High-Speed Data
- Low-Level Input Fail-Safe Detection
- ♦ +3.0V to +3.6V Supply Voltage Range
- LVCMOS/LVTTL Logic Inputs

Ordering Information

PART	TEMP RANGE	PIN- PACKAGE	PKG CODE
MAX9396EHJ+	-40°C to +85°C	32 TQFP	H32-1

+Denotes a lead-free package.

Typical Operating Circuit



Maxim Integrated Products 1

For pricing, delivery, and ordering information, please contact Maxim/Dallas Direct! at 1-888-629-4642, or visit Maxim's website at www.maxim-ic.com.

MAX9396

ABSOLUTE MAXIMUM RATINGS

V _{CC} to GND0.3V to +4.1V
N, ĪN, OUT, OUT, EN, BSEL, LB_SEL_
to GND0.3V to (V _{CC} + 0.3V)
N to <u>IN</u> ±3V
Short-Circuit Duration (OUT, OUT)Continuous
Continuous Power Dissipation ($T_A = +70^{\circ}C$)
32-Pin TQFP (derate 13.1mW/°C above +70°C)1047mW
Junction-to-Ambient Thermal Resistance in Still Air
32-Pin TQFP+76.4°C/W

Operating Temperature Range	40°C to +85°C
Junction Temperature	+150°C
Storage Temperature Range	
ESD Protection (Human Body Model)	
(IN, ĪN, OUT, OUT, EN, B	SEL, LB_SEL_)±2kV
Lead Temperature (soldering, 10s)	+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC ELECTRICAL CHARACTERISTICS

 $(V_{CC} = +3.0V \text{ to } +3.6V, \text{ R}_{L} = 100\Omega \pm 1\%, \text{ EN}_{-} = \text{V}_{CC}, \text{ V}_{CM} = +0.6V \text{ to } (\text{V}_{CC} - 0.05V), \text{ T}_{A} = -40^{\circ}\text{C} \text{ to } +85^{\circ}\text{C}, \text{ unless otherwise noted}.$ Typical values are at V_{CC} = +3.3V, |V_{ID}| = 0.2V, V_{CM} = +1.2V, \text{ T}_{A} = +25^{\circ}\text{C}.) (Notes 1, 2, \text{ and } 3)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS
LVCMOS/LVTTL INPUTS (EN,	BSEL, LB_S	;EL_)	•			
Input High Voltage	VIH		2.0		V _{CC}	V
Input Low Voltage	VIL		0		0.8	V
Input High Current	Ιн	V_{IN} = +2.0V to V _{CC}	0		20	μA
Input Low Current	١ _١ ٢	$V_{IN} = 0V \text{ to } +0.8V$	-1		+10	μA
DIFFERENTIAL INPUTS (IN, \overline{IN}	ī)					
Differential Input Voltage	VID	$V_{ILD} \ge 0V$ and $V_{IHD} \le V_{CC}$, Figure 1	0.1		3.0	V
Input Common-Mode Range	V _{CM}		0.6		V _{CC} - 0.05	V
Single-Ended Input Current	I _{IN} , I <u>IN_</u> _	$ V_{ID} \le 3.0V$ ($V_{IN} = 0V$ to +V _{CC} , IN, or IN open)	-15		+200	μA
Differential Input Termination	R _{IN}	$IN_to \overline{IN}_{-}$	80	100	120	Ω
LVDS OUTPUTS (OUT, OUT	_)					
Differential Output Voltage	V _{OD}	$R_L = 100\Omega$, Figure 2	450	540	600	mV
Change in Magnitude of V _{OD} Between Complementary Output States	ΔV_{OD}	Figure 2			50	mV
Offset Common-Mode Voltage	V _{OS}	Figure 2	1.4	1.5	1.6	V
Change in Magnitude of V _{OS} Between Complementary Output States	ΔV _{OS}	Figure 2			50	mV

DC ELECTRICAL CHARACTERISTICS (continued)

 $(V_{CC} = +3.0V \text{ to } +3.6V, R_L = 100\Omega \pm 1\%, EN_{-} = V_{CC}, V_{CM} = +0.6V \text{ to } (V_{CC} - 0.05V), T_A = -40^{\circ}C \text{ to } +85^{\circ}C, \text{ unless otherwise noted.}$ Typical values are at $V_{CC} = +3.3V, |V_{ID}| = 0.2V, V_{CM} = +1.2V, T_A = +25^{\circ}C.)$ (Notes 1, 2, and 3)

PARAMETER	SYMBOL	CO	NDITIONS	MIN	ТҮР	МАХ	UNITS
Output Chart Circuit Ourreat			V_{OUT} or V_{OUT} = 0V		28	40	
Output Short-Circuit Current (Output(s) Shorted to GND)		· /	V _{OUT_} = V _{OUT_} = 0V		17	24	mA
Output Short-Circuit Current (Outputs Shorted Together)	llosbl	$V_{ID} = \pm 100 \text{mV}, V_{OUT} = V_{\overline{OUT}}$ (Note 4)				12	mA
SUPPLY CURRENT							
		$R_L = 100\Omega$, EN	= V _{CC}		56	75	
Supply Current	Icc	R _L = 100Ω, EN 625MHz (1.25Gbp	= V _{CC} , switching at s)		56	75	mA

AC ELECTRICAL CHARACTERISTICS

 $(V_{CC} = +3.0V \text{ to } +3.6V, \text{ } f_{IN} \leq 625 \text{MHz}, \text{ } t_{R_{-}IN} = \text{t}_{F_{-}IN} = 125 \text{ps}, \text{ } R_{L} = 100 \Omega \pm 1\%, \text{ } \text{IV}_{ID} \text{I} \geq 150 \text{mV}, \text{ } \text{V}_{CM} = +0.6 \text{V} \text{ to } (\text{V}_{CC} - 0.075 \text{V}), \text{ } \text{EN}_{-} = \text{V}_{CC}, \text{ } \text{T}_{A} = -40^{\circ}\text{C} \text{ to } +85^{\circ}\text{C}, \text{ } \text{unless otherwise noted}. \text{ } \text{Typical values are at } \text{V}_{CC} = +3.3 \text{V}, \text{ } \text{IV}_{ID} \text{I} = 0.2 \text{V}, \text{ } \text{V}_{CM} = +1.2 \text{V}, \text{ } \text{f}_{IN} = 625 \text{MHz}, \text{ } \text{T}_{A} = +25^{\circ}\text{C}.) \text{ } (\text{Note 5})$

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS
SEL to Switched Output	tswitch	Figure 3			1.1	ns
Disable Time to Differential Output Low	^t PHD	Figure 4			1.7	ns
Enable Time to Differential Output High	^t PDH	Figure 4			1.7	ns
Data Rate	fDR	$V_{OD} \ge 450 \text{mV}, 2^{23} - 1 \text{ PRBS}$	1.25			Gbps
Low-to-High Propagation Delay	t _{PLH}	Figures 1, 5	250	340	630	ps
High-to-Low Propagation Delay	t _{PHL}	Figures 1, 5	250	355	630	ps
Pulse Skew It _{PLH} – t _{PHL} I	t SKEW	Figures 1, 5 (Note 6)		18	86	ps
Output Channel-to-Channel Skew	tccs	Figure 6 (Note 7)			87	ps
Output Low-to-High Transition Time (20% to 80%)	t _R	$f_{IN_{-}} = 100MHz$, Figures 1, 5	170	220	350	ps
Output High-to-Low Transition Time (80% to 20%)	tF	f _{IN} = 100MHz, Figures 1, 5	170	210	350	ps
Added Random Jitter	t _{RJ}	f _{IN_} = 625MHz, clock pattern (Note 8)		0.45	2	ps(RMS)
Added Deterministic Jitter	t _{DJ}	1.25Gbps, 2 ²³ - 1 PRBS (Note 8)		57	120	psp-p

Note 1: Measurements obtained with the device in thermal equilibrium. All voltages referenced to GND except V_{ID} , V_{OD} , and ΔV_{OD} . **Note 2:** Current into the device defined as positive. Current out of the device defined as negative.

Note 3: DC parameters are production tested at $T_A = +25^{\circ}$ C and guaranteed by design and characterization for $T_A = -40^{\circ}$ C to $+85^{\circ}$ C. **Note 4:** Current through either output.

Note 5: Guaranteed by design and characterization. Limits set at ±6 sigma.

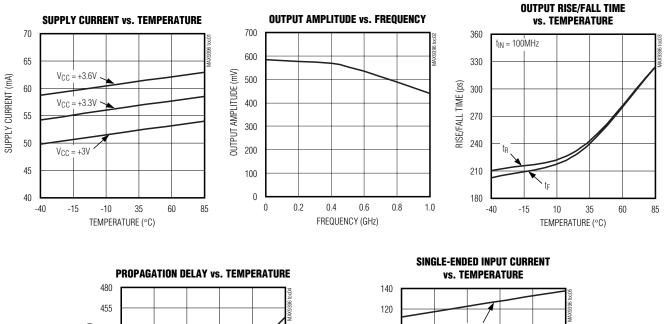
Note 6: t_{SKEW} is the magnitude difference of differential propagation delays for the same output over the same conditions. t_{SKEW} = lt_{PHL} - t_{PLH}I.

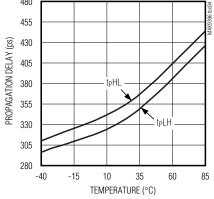
Note 7: Measured between outputs of the same device at the signal crossing points for a same-edge transition under the same conditions. Does not apply to loopback mode.

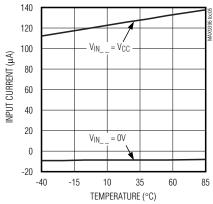
Note 8: Device jitter added to the differential input signal.



Typical Operating Characteristics (V_{CC} = +3.3V, IV_{ID}I = 0.2V, V_{CM} = +1.2V, T_A = +25°C, f_{IN} = 6.25MHz, Figure 5.)







_Pin Description

PIN	NAME	FUNCTION
1, 2, 3, 30, 31, 32	N.C.	No Connection. Not internally connected.
4, 9, 20, 25	GND	Ground
5	ENB	Channel B Output Enable. Drive ENB high to enable the LVDS outputs for channel B. An internal $435k\Omega$ resistor to GND pulls ENB low when unconnected.
6	OUTB	Channel B LVDS Noninverting Output
7	OUTB	Channel B LVDS Inverting Output
8, 13, 24, 29	Vcc	Power-Supply Input. Bypass each V _{CC} to GND with a 0.1μ F and 0.01μ F ceramic capacitor. Install both bypass capacitors as close as possible to the device, with the 0.01μ F capacitor closest to the device.
10	INBO	LVPECL/CML Inverting Input. An internal $68k\Omega$ resistor to GND pulls the input low when unconnected.
11	INB0	LVPECL/CML Noninverting Input. An internal $68k\Omega$ resistor to GND pulls the input low when unconnected.
12	LB_SELB	Loopback Select for Channel B Output. Connect LB_SELB to GND or leave unconnected to reproduce the INB_ (INB_) differential inputs at OUTB (OUTB). Connect LB_SELB to V _{CC} to loop back the INA (INA) differential inputs to OUTB (OUTB). An internal $435k\Omega$ resistor to GND pulls LB_SELB low when unconnected.
14	ĪNB1	LVPECL/CML Inverting Input. An internal $68k\Omega$ resistor to GND pulls the input low when unconnected.
15	INB1	LVPECL/CML Noninverting Input. An internal $68k\Omega$ resistor to GND pulls the input low when unconnected.
16	BSEL	Channel B Multiplexer Control Input. Selects the differential input to reproduce at the B channel differential output. Connect BSEL to GND or leave unconnected to select the INB0 (INB0) set of inputs. Connect BSEL to V _{CC} to select the INB1 (INB1) set of inputs. An internal $435k\Omega$ resistor to GND pulls BSEL low when unconnected.
17	ENA1	Channel A1 Output Enable. Drive ENA1 high to enable the A1 LVDS outputs. An internal $435k\Omega$ resistor to GND pulls the ENA1 low when unconnected.
18	OUTA1	Channel A1 LVDS Inverting Output
19	OUTA1	Channel A1 LVDS Noninverting Output

Pin Description (continued)

PIN	NAME	FUNCTION
21	ENA0	Channel A0 Output Enable. Drive ENA0 high to enable the A0 LVDS outputs. An internal $435k\Omega$ resistor to GND pulls ENA0 low when unconnected.
22	OUTAO	Channel A0 LVDS Inverting Output
23	OUTA0	Channel A0 LVDS Noninverting Output
26	INA	LVPECL/CML Noninverting Input. An internal $68k\Omega$ resistor to GND pulls the input low when unconnected.
27	ĪNĀ	LVPECL/CML Inverting Input. An internal 68k Ω resistor to GND pulls the input low when unconnected.
28	LB_SELA	Loopback Select for Channel A Output. Connect LB_SELA to GND or leave unconnected to reproduce the INA (INA) differential inputs at OUTA_ (OUTA_). Connect LB_SELA to V _{CC} to loop back the INB_ (INB_) differential inputs to OUTA_ (OUTA_). An internal 435k Ω resistor to GND pulls LB_SELA low when unconnected.

Detailed Description

The MAX9396 high-speed, low-power 2:1 multiplexer and 1:2 demultiplexer with loopback provides signal redundancy switching in telecom and storage applications. This device selects one of two remote signal sources for local input and buffers a single local output signal to two remote receivers.

The multiplexer section (channel B) accepts two differential inputs and generates a single LVDS-compatible output. The demultiplexer section (channel A) accepts a single differential input and generates two parallel LVDScompatible outputs. The MAX9396 features a loopback mode that connects the input of channel A to the output of channel B and connects the selected input of channel B to the outputs of channel A. LB_SELA and LB_SELB provide independent loopback control for each channel.

Three LVCMOS/LVTTL logic inputs control the internal connections between inputs and outputs, one for the multiplexer portion of channel B (BSEL), and the other two for loopback control of channels A and B (LB_SELA and LB_SELB). Independent enable inputs for each differential output pair provide additional flexibility.

Input Fail-Safe

The differential inputs of the MAX9396 possess internal fail-safe protection. Fail-safe circuitry forces the outputs to a differential-low condition for undriven inputs or when the common-mode voltage is below +0.6V. The MAX9396 provides low-level input fail-safe detection for LVPECL, CML, and other V_{CC}-referenced differential inputs.

Select Function

BSEL selects the differential input pair to transmit through OUTB (OUTB) for LB_SELB = GND or through OUTA_ (OUTA_) for LB_SELA = V_{CC}. LB_SEL_ controls the loopback function for each channel. Connect LB_SEL_ to GND to select the normal inputs for each channel. Connect LB_SEL_ to V_{CC} to enable the loopback function. The loopback function routes the input of channel A to the output of channel B, and the inputs of channel B to the outputs of channel A. See Tables 1 and 2 for a summary of the input/output routing between channels.

Enable Function

The EN_ logic inputs enable and disable each set of differential outputs. For example, connect ENA0 to V_{CC} to enable the OUTA0/OUTA0 differential output pair or connect ENA0 to GND to disable the OUTA0/OUTA0 differential output pair. The differential output pairs assert to a differential low condition when disabled.

Applications Information

Differential Inputs

The MAX9396 inputs accept any differential signaling standard within the specified common-mode voltage range. The fail-safe feature detects common-mode input signal levels and generates a differential output low condition for undriven inputs or when the common-mode voltage is below +0.6V. Leave unused inputs unconnected or connect to GND.

Power-Supply Bypassing

Bypass each V_{CC} to GND with high-frequency surfacemount ceramic 0.1μ F and 0.01μ F capacitors in parallel as close as possible to the device. Install the 0.01μ F capacitor closest to the device.

Differential Traces

Input and output trace characteristics affect the performance of the MAX9396. Connect each input and output to a 50 Ω characteristic impedance trace. Maintain the distance between differential traces and eliminate sharp corners to avoid discontinuities in differential impedance and maximize common-mode noise immunity. Minimize the number of vias on the differential input and output traces to prevent impedance discontinuities. Reduce reflections by maintaining the 50 Ω characteristic impedance through connectors and across cables. Minimize skew by matching the electrical length of the traces.

Output Termination

Terminate the transmission line with a 100 $\!\Omega$ resistor at the receiver inputs for proper operation.

Ensure that the output currents do not exceed the current limits specified in the *Absolute Maximum Ratings*. Observe the total thermal limits of the MAX9396 under all operating conditions.

Cables and Connectors

Use matched differential impedance for transmission media. Use cables and connectors with matched differential impedance to minimize impedance discontinuities. Avoid the use of unbalanced cables.

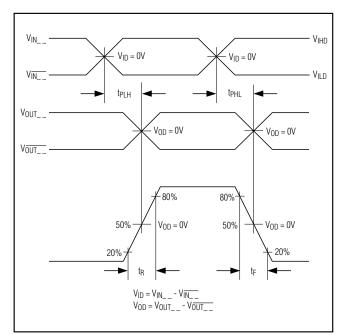


Figure 1. Output Transition Time and Propagation Delay Timing Diagram

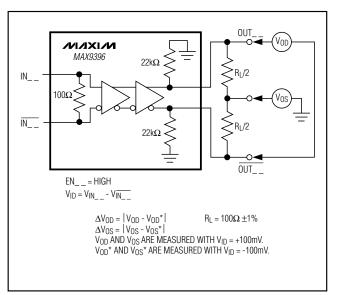


Figure 2. Test Circuit for VOD and VOS

Balanced cables, such as twisted pair, offer superior signal quality and tend to generate less EMI due to canceling effects.

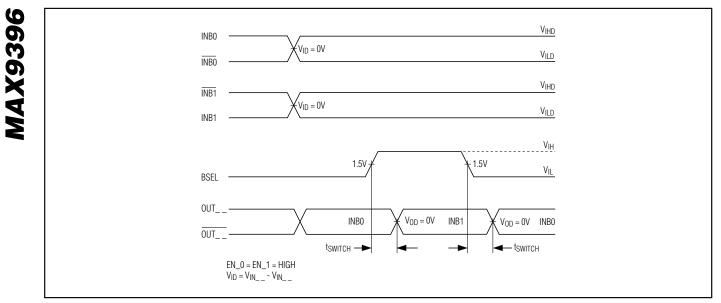


Figure 3. Input to Rising/Falling Edge Select and Mux Switch Timing Diagram

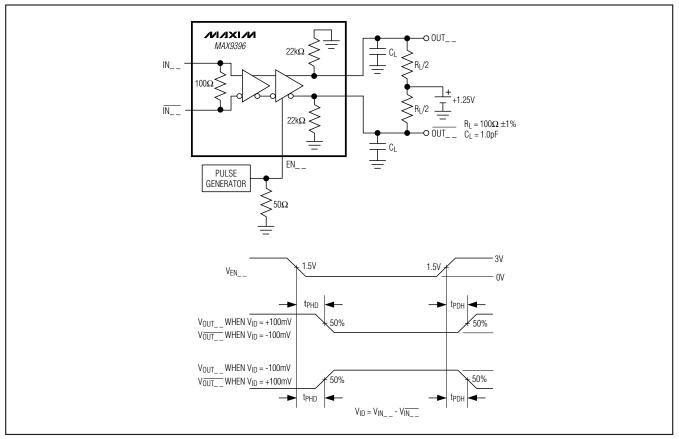


Figure 4. Output Active-to-Disable and Disable-to-Active Test Circuit and Timing Diagram



Table 1. Input Select Truth Table

	LOGIC INPUTS		DIFFERENTIAL OUTPUTS		
LB_SELA	LB_SELB	BSEL	OUTA_/OUTA_ OUTB/OUTB/OUTB/OUTB/OUTB/OUTB/OUTB/OUTB/		
0	0	0	INA selected	INB0 selected	
0	0	1	INA selected	INB1 selected	
0	1	Х	INA selected	INA selected	
1	0	0	INB0 selected	INB0 selected	
1	0	1	INB1 selected	INB1 selected	
1	1	0	INB0 selected	INA selected	
1	1	1	INB1 selected	INA selected	

X = Don't care.

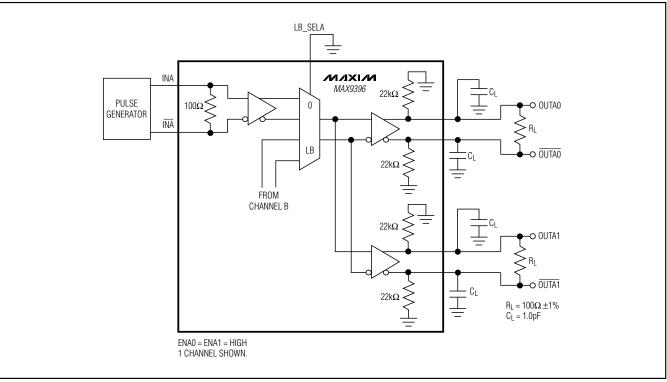


Figure 5. Output Transition Time, Propagation Delay, and Output Channel-to-Channel Skew Test Circuit

PCB Layout

Use a four-layer PCB providing separate signal, power, and ground planes for high-speed signaling applications. Bypass V_{CC} to GND as close as possible to the device. Install termination resistors as close as possible to the receiver inputs. Match the electrical length of the differential traces to minimize signal skew.

Table 2. Loopback Select Truth Table

LB_SEL_	OUT
GND or open	Normal inputs selected.
V _{CC}	Loopback inputs selected.

MAX9396

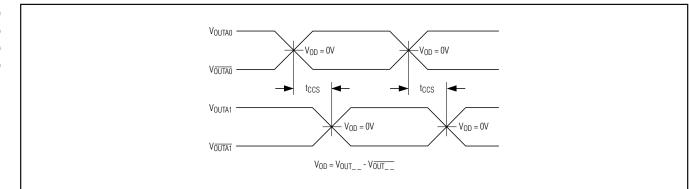
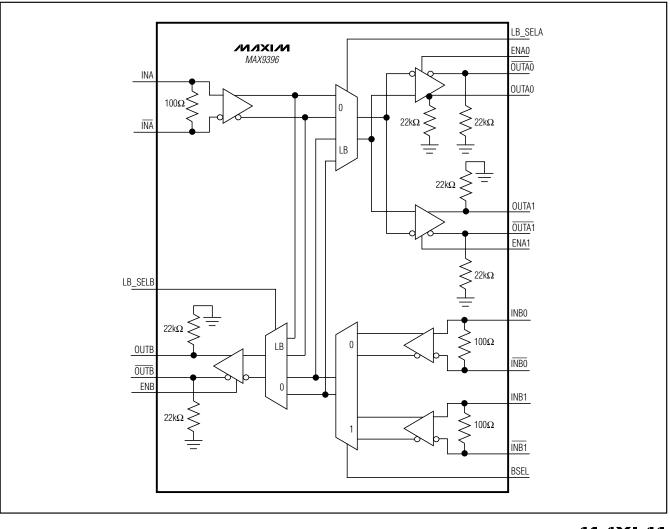
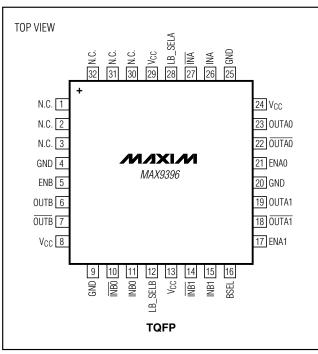


Figure 6. Output Channel-to-Channel Skew



Functional Diagram



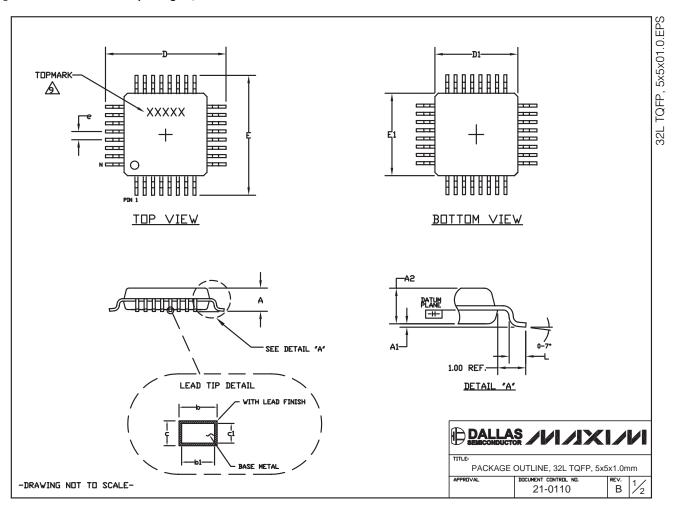
_Pin Configuration

_Chip Information

PROCESS: BICMOS

Package Information

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information, go to **www.maxim-ic.com/packages**.)



Package Information (continued)

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information, go to www.maxim-ic.com/packages.)

2. DATUM PLANE 🖽 IS LOCATED AT MOLD PARTING LINE AND COINCIDENT WITH LEAD, WHERE LEAD EXITS PLASTIC BODY AT BOTTOM OF PARTING LINE.			ARIATIONS
3. DIMENSIONS D1 AND E1 D0 NOT INCLUDE MOLD PROTRUSION. ALLOWABLE MOLD PROTRUSION IS 0.25 MM ON D1 AND E1		A	AA
DIMENSIONS.		5x5x1	1.0 MM
 THE TOP OF PACKAGE IS SMALLER THAN THE BOTTOM OF PACKAGE BY 0.15 MILLIMETERS. 		MIN.	MAX.
5. DIMENSION & DOES NOT INCLUDE DAMBAR PROTRUSION, ALLOWABLE		ne	1,20
DAMBAR PROTRUSION SHALL BE 0.08 MM TOTAL IN EXCESS OF THE © DIMENSION AT MAXIMUM MATERIAL CONDITION.	A1	0.05	0.15
6. ALL DIMENSIONS ARE IN MILLIMETERS.	Az	0.95	1.05
7. THIS DUTLINE CONFORMS TO JEDEC PUBLICATION 95, REGISTRATION	D	6.80	7.20
MS-026. 8. LEADS SHALL BE COPLANAR WITHIN ,004 INCH.	 D1	4.80	5.20
9. TUPMARK SHOWN IS FOR PACKAGE ORIENTATION REFERENCE ONLY.	E	6.80	7.20
	E1	4.80	5.20
	L	0.45	0.75
	N	3	32
	e	0.50	BSC.
	ю	0.17	0.27
	b1	0.17	0.23
	с	0.09	0.20
	c1	0.09	0.16
			1/JXI
	TITLE		, 32L TQFP, 5x5x
	AFFRUVAL		0110

MAX9396

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MAX9396

Part Number Table

Notes:	
1.	See the MAX9396 QuickView Data Sheet for further information on this product family or download the MAX9396 full data sheet (PDF, 168kB).
2.	Other options and links for purchasing parts are listed at: http://www.maxim-ic.com/sales.
3.	Didn't Find What You Need? Ask our applications engineers. Expert assistance in finding parts, usually within one business day.
4.	Part number suffixes: T or T&R = tape and reel; + = RoHS/lead-free; # = RoHS/lead-exempt. More: See full data sheet or Part Naming Conventions.
5.	* Some packages have variations, listed on the drawing. "PkgCode/Variation" tells which variation the product uses.

Part Number	Free Sample	Buy Direct	Package: TYPE PINS SIZE DRAWING CODE/VAR *	Тетр	RoHS/Lead-Free? Materials Analysis
MAX9396EHJ+	Sample	Buy	TQFP;32 pin;5x5x1.0mm Dwg: 21-0110B (PDF)	-40°C to +85°C	RoHS/Lead-Free: Yes
			Use pkgcode/variation: H32+1*		Materials Analysis
MAX9396EHJ+T		Buy	TQFP;32 pin;5x5x1.0mm Dwg: 21-0110B (PDF) Use pkgcode/variation: H32+1*	-40°C to +85°C	RoHS/Lead-Free: Yes
					Materials Analysis

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